

Notice of References Cited	Application/Control No. 10/622,015	Applicant(s)/Patent Under Reexamination COWLES ET AL.	
	Examiner Maureen M. Wallenhorst	Art Unit 1743	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,481,178	11-1984	Kray, William D.	423/342
*	B	US-4,529,707	07-1985	Cowles et al.	436/72
*	C	US-5,723,644	03-1998	Tzou, Ming-Shin	556/466
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Abstract from article entitled "ICP Emission Spectroscopy Determination of Trace Amounts of Manganese, Iron, Chromium, Vanadium, Titanium, Copper, Nickel and Cobalt", Fenxi Huaxue, vol. 8(1), 1980, pages 44-48.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.